

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005
& ANSI/NCSL Z540-1-1994

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CALIBRATION

Valid until: September 30, 2013

Certificate Number: 1818.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations¹:

I. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
DC Voltage ³ – Measure	(0 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 1000) V	9 μV/V + 0.3 μV 8 μV/V + 0.3 μV 8 μV/V + 0.5 μV 10 μV/V + 30 μV 22 μV/V + 0.1 mV	Agilent 3458A, Option 002
DC Current ³ – Measure	(10 to 100) nA 100 nA to 1 μA (1 to 10) μA (10 to 100) μA (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A (1 to 2) A (2 to 20) A	37 μA/A + 0.04 nA 27 μA/A + 0.04 nA 27 μA/A + 0.1 nA 27 μA/A + 0.8 nA 27 μA/A + 5 nA 27 μA/A + 50 nA 42 μA/A + 0.5 μA 0.012 % + 10 μA 0.021 % + 16 μA 0.046 % + 400 μA	Agilent 3458A, Option 002 Fluke 8508A

Parameter/Equipment	Range	CMC ^{2, 4, 5, 9} (\pm)	Comments
Resistance ³ – Measure	(0 to 10) Ω (10 to 100) Ω (0.1 to 1) k Ω (1 to 10) k Ω (10 to 100) k Ω (0.1 to 1) M Ω (1 to 10) M Ω (10 to 100) M Ω 100 M Ω to 1 G Ω	20 $\mu\Omega/\Omega$ + 50 $\mu\Omega$ 17 $\mu\Omega/\Omega$ + 0.5 m Ω 15 $\mu\Omega/\Omega$ + 0.5 m Ω 15 $\mu\Omega/\Omega$ + 5 m Ω 15 $\mu\Omega/\Omega$ + 50 m Ω 20 $\mu\Omega/\Omega$ + 2 Ω 55 $\mu\Omega/\Omega$ + 100 Ω 0.051 % + 1 k Ω 0.5 % + 10 k Ω	Agilent 3458A, Option 002
DC Voltage ³ – Generate	Up to 0.22 V (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V	10 $\mu\text{V}/\text{V}$ + 0.6 μV 9 $\mu\text{V}/\text{V}$ + 1.0 μV 9 $\mu\text{V}/\text{V}$ + 3.5 μV 9 $\mu\text{V}/\text{V}$ + 6.5 μV 10 $\mu\text{V}/\text{V}$ + 80 μV 11 $\mu\text{V}/\text{V}$ + 500 μV	Fluke 5700A
DC Current ³ – Generate	Up to 220 μA 220 μA to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2.2 to 11) A (11 to 20) A	52 $\mu\text{A}/\text{A}$ + 8 nA 52 $\mu\text{A}/\text{A}$ + 8 nA 52 $\mu\text{A}/\text{A}$ + 80 nA 62 $\mu\text{A}/\text{A}$ + 0.8 μA 82 $\mu\text{A}/\text{A}$ + 25 μA 0.05 % + 500 μA 0.1 % + 750 μA	Fluke 5700A Fluke 5520A
Resistance ³ – Generate, Fixed Points	(1, 1.9) Ω 10 Ω 19 Ω (100, 190) Ω (1, 1.9) k Ω (10, 19) k Ω (100, 190) k Ω 1 M Ω 1.9 M Ω 10 M Ω 19 M Ω 100 M Ω	0.013 % 39 $\mu\Omega/\Omega$ 38 $\mu\Omega/\Omega$ 24 $\mu\Omega/\Omega$ 18 $\mu\Omega/\Omega$ 17 $\mu\Omega/\Omega$ 19 $\mu\Omega/\Omega$ 27 $\mu\Omega/\Omega$ 29 $\mu\Omega/\Omega$ 54 $\mu\Omega/\Omega$ 65 $\mu\Omega/\Omega$ 0.016 %	Fluke 5700A

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Resistance ³ – Generate	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω 330 Ω to 1.1 kΩ (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (3 to 110) kΩ (110 to 330) kΩ 330 kΩ to 1.1 MΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (11 to 33) MΩ (33 to 110) MΩ (110 to 330) MΩ 330 MΩ to 1.1 GΩ	42 μΩ/Ω + 0.001 Ω 32 μΩ/Ω + 0.001 5 Ω 30 μΩ/Ω + 0.001 4 Ω 30 μΩ/Ω + 0.002 Ω 30 μΩ/Ω + 0.002 Ω 30 μΩ/Ω + 0.02 Ω 30 μΩ/Ω + 0.02 Ω 30 μΩ/Ω + 0.2 Ω 30 μΩ/Ω + 0.2 Ω 34 μΩ/Ω + 2 Ω 34 μΩ/Ω + 2 Ω 62 μΩ/Ω + 30 Ω 0.014 % + 50 Ω 0.026 % + 2.5 kΩ 0.051 % + 3 kΩ 0.3 % + 100 kΩ 1.5 % + 500 kΩ	Fluke 5520A
Electrical Simulation of Thermocouple Indicators ³ –			
Type B	(600 to 800) °C (800 to 1000) °C (1000 to 1550) °C (1550 to 1820) °C	0.44 °C 0.34 °C 0.30 °C 0.33 °C	Fluke 5520A
Type C	(0 to 150) °C (150 to 650) °C (650 to 1000) °C (1000 to 1800) °C (1800 to 2316) °C	0.30 °C 0.26 °C 0.31 °C 0.50 °C 0.84 °C	
Type E	(-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1000) °C	0.50 °C 0.16 °C 0.14 °C 0.16 °C 0.21 °C	
Type J	(-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1200) °C	0.27 °C 0.16 °C 0.14 °C 0.17 °C 0.23 °C	

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Simulation of Thermocouple Indicators ³ – (cont)			
Type K	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1000) °C (1000 to 1372) °C	0.33 °C 0.18 °C 0.16 °C 0.26 °C 0.40 °C	Fluke 5520A
Type L	(-200 to -100) °C (-100 to 800) °C (800 to 900) °C	0.37 °C 0.26 °C 0.17 °C	
Type N	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 410) °C (410 to 1300) °C	0.40 °C 0.22 °C 0.19 °C 0.18 °C 0.27 °C	
Type R	(0 to 250) °C (250 to 400) °C (400 to 1000) °C (1000 to 1767) °C	0.57 °C 0.35 °C 0.33 °C 0.40 °C	
Type S	(0 to 250) °C (250 to 1000) °C (1000 to 1400) °C (1400 to 1767) °C	0.47 °C 0.36 °C 0.37 °C 0.46 °C	
Type T	(-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.63 °C 0.24 °C 0.16 °C 0.14 °C	
Type U	(-200 to 0) °C (0 to 600) °C	0.56 °C 0.27 °C	

Parameter/Range	Frequency	CMC ^{2,4,9} (±)	Comments
AC Voltage Flatness ³ – Measure (0.5, 1 or 3) V	10 Hz to 10 MHz (10 to 30) MHz (30 to 60) MHz (60 to 100) MHz	0.13 % 0.25 % 0.5 % 1.5 %	Agilent 11049A, 11050A, Precision Measurements EL 1300
AC Voltage ³ – Generate Up to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.056 % + 4.5 μV 0.022 % + 4.5 μV 0.011 % + 4.5 μV 0.038 % + 4.5 μV 0.086 % + 7 μV 0.11 % + 13 μV 0.17 % + 25 μV 0.34 % + 25 μV	Fluke 5700A
(2.2 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.056 % + 5 μV 0.022 % + 5 μV 0.011 % + 5 μV 0.038 % + 5 μV 0.086 % + 7 μV 0.11 % + 12 μV 0.17 % + 25 μV 0.34 % + 25 μV	
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.056 % + 13 μV 0.022 % + 8 μV 0.011 % + 8 μV 0.033 % + 8 μV 0.086 % + 25 μV 0.11 % + 25 μV 0.17 % + 35 μV 0.34 % + 80 μV	
220 mV to 2.2 V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.051 % + 80 μV 0.017 % + 25 μV 0.008 % + 6 μV 0.013 % + 16 μV 0.026 % + 70 μV 0.044 % + 130 μV 0.11 % + 0.35 mV 0.23 % + 0.85 mV	

Parameter/Range	Frequency	CMC ^{2,4,9} (±)	Comments
AC Voltage ³ – Generate (cont)			
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.051 % + 800 μV 0.017 % + 250 μV 0.008 % + 60 μV 0.013 % + 160 μV 0.026 % + 350 μV 0.051 % + 1.5 mV 0.13 % + 4.3 mV 0.27 % + 8.5 mV	Fluke 5700A
(22 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.051 % + 8 mV 0.017 % + 2.5 mV 0.009 % + 0.8 mV 0.023 % + 3.5 mV 0.051 % + 8 mV 0.15 % + 90 mV 0.47 % + 90 mV 1.2 % + 190 mV	
(220 to 250) V	(15 to 50) Hz	0.041 % + 16 mV	
(220 to 1100) V	50 Hz to 1 kHz	82 μV/V + 3.5 mV	
Inductance ³ – Measure			
10 μH to 100 H	100 Hz; 120 Hz	0.1 % + 1 μH	GenRad 1659 Digibridge
1 μH to 10 H	1 kHz	0.1 % + 0.1 μH	
0.1 μH to 1 H	10 kHz	0.1 % + 0.02 μH	

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comments
DC High Voltage ³ – Generate	(1 to 10) kV (10 to 20) kV (21 to 50) kV	0.08 % + 0.004 kV 0.2 % 0.4 %	Glassman high voltage PS-EK 50N12.0-11 w/ Vitrek 4670A

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comments
DC High Voltage ³ – Measure	(1 to 10) kV (10 to 20) kV (21 to 70) kV	0.08 % + 0.004 kV 0.2 % 0.4 %	Vitrek 4670A
AC High Voltage ³ – Measure			
(20 to 100) Hz	(1 to 10) kV _{rms} AC (10 to 20) kV _{rms} AC	0.2 % + 0.025 kV 0.5 %	Vitrek 4670A
(50 to 60) Hz	(20 to 35) kV _{rms} AC	0.4 % + 0.11 kV	

Parameter/Range	Frequency	CMC ^{2,4} (±)	Comments
AC Current ³ – Generate			
Up to 220 µA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.03 % + 20 nA 0.02 % + 12 nA 0.014 % + 10 nA 0.035 % + 15 nA 0.13 % + 80 nA	Fluke 5700A
220 µA to 2.2 mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.03 % + 50 nA 0.02 % + 40 nA 0.014 % + 40 nA 0.024 % + 130 nA 1.3 % + 0.8 µA	
(2.2 to 22) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.03 % + 0.5 µA 0.02 % + 0.4 µA 0.014 % + 0.4 µA 0.024 % + 0.7 µA 1.3 % + 6 µA	
(22 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.03 % + 5 µA 0.02 % + 4 µA 0.014 % + 3 µA 0.024 % + 4 µA 1.3 % + 12 µA	
220 mA to 2.2 A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.032 % + 40 µA 0.05 % + 100 µA 0.8 % + 200 µA	

Parameter/Range	Frequency	CMC ^{2,4,5} (±)	Comments
AC Current ³ – Generate (cont)			
(2.2 to 3) A	(10 to 100) Hz (100 to 440) Hz	0.12 % + 200 µA 0.3 % + 1 mA	Fluke 5700A
(3 to 20) A	(10 to 100) Hz 100 Hz to 1 kHz	0.12 % + 2 mA 1 % + 5 mA	Fluke 5520A
AC Voltage ³ – Measure			
(1 to 10) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.03 % + 3 µV 0.02 % + 1.1 µV 0.03 % + 1.1 µV 0.1 % + 1.1 µV 0.5 % + 1.1 µV 4 % + 2 µV	Agilent 3458A, option 002
(10 to 100) mV	(1 Hz to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	72 µV/V + 4 µV 72 µV/V + 2 µV 0.015 % + 2 µV 0.03 % + 2 µV 0.08 % + 2 µV 0.3 % + 1 µV 1 % + 1 µV 1.5 % + 1 µV	
100 mV to 1 V	(1 Hz to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	72 µV/V + 40 µV 72 µV/V + 20 µV 0.015 % + 20 µV 0.03 % + 20 µV 0.08 % + 20 µV 0.3 % + 10 µV 1 % + 10 µV 1.5 % + 10 µV	
(1 to 10) V	(1 Hz to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	72 µV/V + 400 µV 72 µV/V + 200 µV 0.015 % + 200 µV 0.03 % + 200 µV 0.08 % + 200 µV 0.3 % + 100 µV 1 % + 100 µV 1.5 % + 100 µV	

Parameter/Range	Frequency	CMC ^{2,5} (\pm)	Comments
AC Voltage ³ – Measure (cont)			
(10 to 100) V	(1 Hz to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.02 % + 4 mV 0.02 % + 2 mV 0.02 % + 2 mV 0.035 % + 2 mV 0.12 % + 2 mV 0.4 % + 1 mV 1.5 % + 1 mV	Agilent 3458A, option 002
(100 to 1000) V	(1 Hz to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.04 % + 40 mV 0.04 % + 20 mV 0.06 % + 20 mV 1.2 % + 20 mV 3 % + 20 mV	
AC Current ³ – Measure			
(5 to 100) μ A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.4 % + 30 nA 0.15 % + 30 nA 0.06 % + 30 nA 0.06 % + 30 nA	Agilent 3458A, option 002
100 μ A to 1 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.4 % + 200 nA 0.15 % + 200 nA 0.06 % + 200 nA 0.03 % + 200 nA 0.06 % + 200 nA 0.4 % + 400 nA 0.55 % + 1.5 μ A	
(1 to 10) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.4 % + 0.2 μ A 0.15 % + 0.2 μ A 0.06 % + 0.2 μ A 0.03 % + 0.2 μ A 0.06 % + 0.2 μ A 0.4 % + 0.4 μ A 0.55 % + 15 μ A	

Parameter/Equipment	Frequency	CMC ^{2, 4, 5, 9} (\pm)	Comments
AC Current ³ – Measure (cont)			
(10 to 100) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.4 % + 2 μ A 0.15 % + 2 μ A 0.06 % + 2 μ A 0.03 % + 2 μ A 0.06 % + 2 μ A 0.4 % + 4 μ A 0.55 % + 150 μ A	Agilent 3458A, option 002
100 mA to 1 A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (5 to 20) kHz (20 to 50) kHz	0.4 % + 20 μ A 0.16 % + 20 μ A 0.08 % + 20 μ A 0.1 % + 20 μ A 0.3 % + 20 μ A 1 % + 40 μ A	
(1 to 2) A	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.071 % + 240 μ A 0.082 % + 240 μ A 0.3 % + 240 μ A	Fluke 8508A
(2 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.09 % + 2.4 mA 0.25 % + 2.4 mA	
Capacitance ³ – Measure			
20 pF to 100 μ F	100 Hz; 120 Hz	0.1 % + 2 pF	GenRad 1659 RLC Digibridge
1 pF to 10 μ F	1 kHz	0.1 % + 1 pF	
0.1 pF to 1 μ F	10 kHz	0.1 % + 0.1 pF	

Parameter/Equipment	Frequency	CMC ^{2,4,9} (±)	Comments
Capacitance ³ – Generate (0.2 to 0.4) nF (0.4 to 1.1) nF (1.1 to 3.3) nF (3.3 to 11) nF (11 to 33) nF (33 to 110) nF (110 to 330) nF 330 nF to 1.1 µF (1.1 to 3.3) µF (3.3 to 11) µF (11 to 33) µF (33 to 110) µF (110 to 330) µF 330 µF to 1.1 mF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF (33 to 110) mF	10 Hz to 10 kHz 10 Hz to 10 kHz 10 Hz to 3 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz (10 to 600) Hz (10 to 300) Hz (10 to 150) Hz (10 to 120) Hz (10 to 80) Hz (0 to 50) Hz (0 to 20) Hz (0 to 6) Hz (0 to 2) Hz (0 to 0.6) Hz (0 to 0.2) Hz	0.5 % + 0.01 nF 0.5 % + 0.01 nF 0.5 % + 0.01 nF 0.25 % + 0.01 nF 0.25 % + 0.1 nF 0.25 % + 0.1 nF 0.25 % + 0.3 nF 0.25 % + 1 nF 0.25 % + 3 nF 0.25 % + 10 nF 0.4 % + 30 nF 0.45 % + 100 nF 0.45 % + 300 nF 0.45 % + 1 µF 0.45 % + 3 µF 0.45 % + 10 µF 0.75 % + 30 µF 1.1 % + 100 µF	Fluke 5520A
Oscilloscope Calibration ³ – Generate Voltage – DC – 1 MΩ DC – 50 Ω Square Wave – 50 Ω Rise Time Timing Leveled Sine Wave Amplitude Single	1 mV to 200 V 1 mV to 5 V (0.04 to 1) mV 1 mV to 5 V 150 ps @ 5 mV to 3V 70 ps @ 25 mV to 2 V 25 ps @ (425 to 575) mV Narrow Triangle 900.91 ns to 55 s 5 mV to 5 V	0.03 % + 25 µV 0.03 % + 25 µV 1.5 % + 10 µV 0.12 % + 10 µV 27 ps 20 ps 8 ps 3.4 µs/s 1.5 % 2 % 2.5 % 3.5 % 5 %	Fluke 9500B with 9530, 9550 and 9560 heads

Parameter/Equipment	Frequency	CMC ^{2,9} (±)	Comments
Oscilloscope Calibration ³ – Generate (cont)			
Leveled Sine Wave			
Dual	wrt Reference Frequency: 0.1 Hz to 1 GHz (1 to 3.2) GHz	10 % 25 %	Fluke 9500B with 9530, 9550 and 9560 heads
Pulse Width	(1 to 100) ns	5 % + 200 ps	

II. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC ^{2,6,7,8,9} (±)	Comments
RF Power Sensor Transfer ³ –			
10 μW to 25 mW	10 MHz to 10 GHz (10 to 18) GHz	1.4 % + <i>M</i> 1.4 % + <i>M</i>	Tegam 1803A w/1805B
	100 kHz to 4.2 GHz	1.4 % + <i>M</i>	Tegam F1119 w/1805B
RF Absolute Power ³ – Measure			
(+20 to -60) dBm	9 kHz to 6 GHz (1 to 6) GHz	1.1 % + <i>M</i> 1.7 % + <i>M</i>	Agilent E9304A
(+20 to -30) dBm	10 MHz to 1 GHz (1 to 2) GHz (2 to 4) GHz (4 to 6) GHz (6 to 8) GHz (8 to 10) GHz (10 to 12) GHz (12 to 14) GHz (14 to 16) GHz (16 to 18) GHz 18 GHz	1.4 % + <i>M</i> 1.6 % + <i>M</i> 1.4 % + <i>M</i> 1.5 % + <i>M</i> 1.5 % + <i>M</i> 1.7 % + <i>M</i> 1.9 % + <i>M</i> 2.1 % + <i>M</i> 2.6 % + <i>M</i> 2.9 % + <i>M</i> 3.2 % + <i>M</i>	Agilent 8481A

Parameter/Range	Frequency	CMC ^{2, 6, 7, 8, 9} (±)	Comments
RF Absolute Power ³ – Measure			
(-30 to -70) dBm	10 MHz to 1 GHz	1.4 % + <i>M</i>	Agilent 8481D
	(1 to 2) GHz	1.9 % + <i>M</i>	
	(2 to 4) GHz	1.8 % + <i>M</i>	
	(4 to 6) GHz	1.8 % + <i>M</i>	
	(6 to 8) GHz	1.8 % + <i>M</i>	
	(8 to 10) GHz	2 % + <i>M</i>	
	(10 to 12) GHz	2.2 % + <i>M</i>	
	(12 to 14) GHz	2.8 % + <i>M</i>	
	(14 to 16) GHz	3.2 % + <i>M</i>	
	(16 to 18) GHz	3.4 % + <i>M</i>	
	18 GHz	3.7 % + <i>M</i>	
(+20 to -30) dBm	50 MHz to 1 GHz	1.3 % + <i>M</i>	Agilent 8487D
	(1 to 2) GHz	1.6 % + <i>M</i>	
	(2 to 4) GHz	1.6 % + <i>M</i>	
	(4 to 6) GHz	1.6 % + <i>M</i>	
	(6 to 8) GHz	1.7 % + <i>M</i>	
	(8 to 10) GHz	1.8 % + <i>M</i>	
	(10 to 12) GHz	1.8 % + <i>M</i>	
	(12 to 14) GHz	1.9 % + <i>M</i>	
	(14 to 16) GHz	2.1 % + <i>M</i>	
	(16 to 18) GHz	2.2 % + <i>M</i>	
	(18 to 22) GHz	2.3 % + <i>M</i>	
	(22 to 26.5) GHz	1.8 % + <i>M</i>	
	(26.5 to 28) GHz	2.1 % + <i>M</i>	
	(28 to 30) GHz	2.3 % + <i>M</i>	
	(30 to 33) GHz	2.1 % + <i>M</i>	
	(33 to 34.5) GHz	2.3 % + <i>M</i>	
	(34.5 to 37) GHz	2.1 % + <i>M</i>	
	(37 to 40) GHz	2.3 % + <i>M</i>	
	(40 to 42) GHz	2.6 % + <i>M</i>	
	(42 to 44) GHz	3.2 % + <i>M</i>	
(44 to 46) GHz	3.6 % + <i>M</i>		
(46 to 48) GHz	4.1 % + <i>M</i>		
(48 to 50) GHz	4.5 % + <i>M</i>		
	50 GHz	5 % + <i>M</i>	

Parameter/Range	Frequency	CMC ^{2, 6, 7, 8, 9} (\pm)	Comments
RF Absolute Power ³ – Measure (cont) (-30 to -70) dBm	50 MHz to 1 GHz (1 to 2) GHz (2 to 4) GHz (4 to 6) GHz (6 to 8) GHz (8 to 10) GHz (10 to 12) GHz (12 to 14) GHz (14 to 16) GHz (16 to 18) GHz (18 to 22) GHz (22 to 26.5) GHz (26.5 to 28) GHz (28 to 30) GHz (30 to 33) GHz (33 to 34.5) GHz (34.5 to 37) GHz (37 to 40) GHz (40 to 42) GHz (42 to 44) GHz (44 to 46) GHz (46 to 48) GHz (48 to 50) GHz 50 GHz	1.7 % + <i>M</i> 2 % + <i>M</i> 2 % + <i>M</i> 2 % + <i>M</i> 2.3 % + <i>M</i> 2.3 % + <i>M</i> 2.3 % + <i>M</i> 2.8 % + <i>M</i> 2.8 % + <i>M</i> 2.8 % + <i>M</i> 2.8 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 3 % + <i>M</i> 2.9 % + <i>M</i> 2.9 % + <i>M</i> 3.1 % + <i>M</i> 4.5 % + <i>M</i> 4.5 % + <i>M</i>	Agilent 8487D
RF Power ³ – Generate (+23 to 0) dBm (+24 to -130) dBm (+14 to -130) dBm (+10 to -110) dBm (+5 to -110) dBm (+2.5 to -110) dBm	1 μ Hz to 80 MHz 10 Hz to 12.5 MHz 12.5 MHz to 4 GHz 10 MHz to 26.5 GHz (26.5 to 40) GHz (40 to 50) GHz	0.1 dB + <i>M</i> 0.05 dB + <i>M</i> 0.06 dB + <i>M</i> 0.6 dB + <i>M</i> 0.8 dB + <i>M</i> 1.5 dB + <i>M</i>	Agilent 33250A Fluke 9640A Agilent 83650B

Parameter/Range	Frequency	CMC ^{2, 6, 7, 8, 9} (±)	Comments
Tuned RF Power Relative ³ – Measure (0 to -3) dBm (-3 to -10) dBm (-10 to -40) dBm (-40 to -50) dBm (-50 to -80) dBm (-80 to -90) dBm (-90 to -110) dBm	2.5 MHz to 26.5 GHz	0.02 dB 0.02 dB 0.08 dB 0.14 dB 0.2 dB 0.26 dB 0.3 dB	Agilent 8902A Agilent 11722A Agilent 11792A Agilent 11793A
Amplitude Modulation ³ – Generate Frequency: 250 kHz to 40 GHz Rates: (0 to 100) kHz	Modulation Depths: 0 % to 100 %	6 % of setting + 1 % 6 % of setting + 1 %	Agilent E8257C
Sine Wave Distortion ³ – Measure 400 Hz and 1000 Hz Modulation	Modulation Depths: 0 % to 90 %	0.84 %	Agilent 8903B
Amplitude Modulation ³ – Measure Rate: 50 Hz to 10 kHz Depth: 5 % to 99 % Rate: 20 Hz to 10 kHz Depth: 0 % to 99 % Rate: 50 Hz to 50 kHz Depth: 5 % to 99 % Rate: 20 Hz to 100 kHz Depth: 0 % to 99 % Rate: 50 Hz to 50 kHz Depth: 5 % to 99 % Rate: 30 Hz to 1 MHz	150 kHz to 10 MHz 150 kHz to 10 MHz (10 to 1300) MHz (10 to 1300) MHz (1.3 to 26.5) GHz (26.5 to 50) GHz	2.5 % 3.6 % 1.6 % 3.6 % 2.1 % 1.4 %	Agilent 8902A Agilent 8902A with 11793A, 11792A Agilent 8565E, option 001

Parameter/Range	Frequency	CMC ^{2,7,8,9} (±)	Comments
Phase Modulation ³ – Measure Rate: 200 Hz to 10 kHz 200 Hz to 20 kHz	(10 to 1300) MHz 10 MHz to 26.5 GHz	3.6 % 4.7 %	Agilent 8902A with 11973A, 11972A
Pulse Repetition Frequency ³ – Measure	3 Hz to 26.5 GHz 30 Hz to 50 GHz	150 Hz 150 Hz	Agilent E4440A Agilent 8565E
Frequency Modulation ³ – Generate 250 kHz to 40 GHz 10 MHz to 50 GHz	For 400 and 1000 Hz internal modulation 1 MHz rate, 1 MHz deviation	3.5 % + 20 Hz 10 %	Agilent E8257C Agilent 83650B
Frequency Modulation ³ – Measure Rate: 20 Hz to 10 kHz Dev.: ≤ 40 kHz peak Rate: 50 Hz to 100 kHz Dev.: ≤ 400 kHz peak Rate: (20 to 200) kHz Dev.: ≤ 400 kHz peak 30 Hz to 1 MHz	250 kHz to 10 MHz (10 to 1300) MHz (0.10 to 26.5) GHz (26.5 to 50) GHz	2.4 % 1.3 % 5.8 % 150 Hz	Agilent 8902A With Agilent 11793A, 1792A Agilent 8565E, option 001
VSWR ³ – Measure	5 Hz to 500 MHz 100 kHz to 50 GHz	0.93 % 1.1 % of indicated value	Agilent 8751A Agilent 8757D with 8721A, 85027C, 85027E, 85027D

III. Time and Frequency

Parameter/Equipment	Frequency	CMC ^{2,7,8} (\pm)	Comments
Frequency ³ – Measuring Equipment	1 μ Hz to 80 MHz 10 Hz to 4 GHz 10 MHz to 50 GHz	2.5 μ Hz/Hz + 1 μ Hz 0.03 nHz/Hz + 0.6 mHz 0.03 nHz/Hz + 0.6 Hz	With GPS conditioning: Agilent 33250 Fluke 9640 Agilent 83650B w/ option 008
Frequency ³ – Measure	0 Hz to 200 MHz 200 MHz to 50 GHz	0.06 nHz/Hz + 25 pHz 0.04 nHz/Hz + 2 Hz	With GPS conditioning: Agilent 5335A, 53132A Agilent 53151A, 53132A, 8565E
Time Interval ³ – Measure	500 ps to 400 s	19 μ Hz/Hz + 24 ps	Tektronix TDS 7404B oscilloscope
10 MHz Source ³ (Rubidium)	10 MHz	0.03 nHz/Hz	Rubidium frequency standard referenced to GPS
Frequency – Measure ³	10 MHz	0.003 nHz/Hz	Agilent 53132A referenced to GPS
Frequency Stability ³	10 MHz	0.01 nHz/Hz for $\tau = 10$ s	Rubidium frequency standard referenced to GPS

IV. Device Specific Parameters

EMI receivers (CISPR 16-1), EFT/Burst Generators (EN 61000-4-4), ESD Guns and Targets (IEC 61000-4-2, ANSI C63.16, SAE J1113-13), Surge Generators (EN 61000-4-5), Generators for Voltage Dips, Short Interrupts and Voltage Variations (EN 61000-4-11), Ring Wave Generators (ANSI C62.41), Network Analyzers, Impulse Generators (CISPR 16-1), Oscilloscopes, Power Meters, Power Sensors, Signal Generators, Spectrum Analyzers, 50 Ω Terminators

Parameter/Equipment	Frequency	CMC ² (±)	Comments
Single Sideband Phase Noise (SSB) ³	(10 to 1300) MHz	1 dB	Agilent 8902A with option 036/037
Frequency Accuracy ³	(1.5, 4, 9, 16, 21) GHz (21, 26.5, 40) GHz	3 kHz	Agilent 8902A
	50 GHz	5 kHz	Agilent 8565E
Span Accuracy ³	1 kHz to 2 MHz	1 Hz	Agilent 3335A Agilent 86350A
	2 MHz to 500 MHz	1 kHz	
Residual FM ³ (At 500 MHz)	5 kHz span and 1 kHz RBW	0.24 kHz	Agilent 3335A Agilent 86350A
Cal Output Port Check ³	300 MHz -20 dBm	1.2 Hz 0.44 dB	Agilent 53132A Agilent E9304A & 8482A (based on Agilent 8593E)
Average Noise ³	9 kHz to 50 GHz	0.31 dB	50 Ω load
Residuals ³	20 Hz to 50 GHz	0.31 dB	50 Ω load
Reference Level ³ –			Agilent 11792 with:
Log Scale	50 MHz	0.14 dB	Agilent 3335A
Linear Scale	50 MHz	0.32 dB	Agilent 83650B (based on Agilent 8593E)

Parameter/Equipment	Frequency	CMC ^{2,9} (\pm)	Comments
Attenuator Check ³	50 MHz	0.15 dB	Agilent 8593E
Log Fidelity ³	50 MHz 50 MHz	1.1 dB 1.1 dB	Agilent 3335A Agilent 83650B (based on Agilent 8593E)
Linear Fidelity ³	50 MHz 50 MHz	1 dB 1 dB	Agilent 3335A Agilent 83650B (based on Agilent 8593E)
BW Accuracy ³	20 Hz to 50 GHz	1 Hz	Agilent 83650B (based on Agilent 8565E)
BW Switching ³	20 Hz to 50 GHz	1.1 dB	Agilent 83650B (based on Agilent 8565E)
2 nd Harmonic Distortion ³	30 Hz to 50 GHz 200 Hz to 80 MHz (10 to 50) GHz	1.4 dB 1.4 dB 1.4 dB	Agilent 8565E Agilent 3335A Agilent 83650B (based on Agilent 8565E)
3 rd Order Intermodulation ³	200 Hz to 80 MHz (10 to 50) GHz	0.5 dB 0.5 dB	Agilent 3335A Agilent 83650B (based on Agilent 8565E)
Noise Sidebands ³	200 Hz to 80 MHz (10 to 50) GHz	0.7 dB 0.8 dB	Agilent 3335A Agilent 83650B (based on Agilent 8565E)
System Sidebands ³	200 Hz to 80 MHz (10 to 50) GHz	0.48 dB 0.52 dB	Agilent 3335A Agilent 83650B (based on Agilent 8565E)
Sweep Time ³	10 MHz to 50 GHz	6.1 %	Agilent 83650B (based on Agilent 8565E)

Parameter/Equipment	Frequency	CMC ^{2,5} (±)	Comments
Harmonic Measurements ³	30 Hz to 50 GHz 200 Hz to 80 MHz (10 to 50) GHz	0.5 dB 0.6 dB 0.8 dB	Agilent 8565E Agilent 3335A Agilent 83650B (based on Agilent 8565E)
Tracking Generator Non-Harmonics ³	9 kHz to 2.9 GHz	0.59 dB	Agilent 8565E
Tracking Generator Feedthrough ³	9 kHz to 2.9 GHz	0.63 dB	50 Ω load, 909F
Tracking Absolute Amplitude Output ³	9 kHz to 2.9 GHz	0.61 dB	Agilent E9304A Agilent E4418B
Frequency Response ³	9 kHz to 40 GHz 50 MHz to 50 GHz	1.1 dB 1.3 dB	Agilent 8902A Agilent 8487A (based on Agilent 8565E)
Gain Compression ³	200 Hz to 80 MHz (10 to 50) GHz	1.5 dB 1.5 dB	Agilent 3335A Agilent 83650B (based on Agilent 8565E)
General RF Insertion Loss/Gain ³	9 kHz to 6 GHz	0.42 dB	Agilent E9304A, Agilent E4418B
	10 MHz to 18 GHz	0.42 dB	Agilent E4412A, Agilent E4418B
	(18 to 26.5) GHz	0.6 dB	Agilent E4418B, 8487A
	(26.5 to 40) GHz	0.8 dB	
(40 to 50) GHz	1.1 dB		

Parameter/Equipment	Frequency	CMC ^{2, 5, 6, 9} (\pm)	Comments
Impedance ³ – Measure, 50 Ω Terminations	30 kHz to 6 GHz	0.93 %	Agilent 8753D, 85032B cal kit, S11 – 1 port calibration
	10 MHz to 18 GHz	0.95 %	Agilent E8364B, N4690A cal kit, S11 – 1 port calibration
	(18 to 50) GHz	1 %	Agilent E8364B, N4693A cal kit, S11 – 1 port calibration
Type N Calibration Kits ³ – Pin Depth	\pm 0.02 in 10 kHz to 18 GHz	560 μ m	Agilent 85054B
Impedance ³ – Measure 50 Ω devices	30 kHz to 6 GHz	$M + 2.9$ %	Agilent 8753D, 85032B cal kit, S11 – 1 port calibration
Attenuation Measurements ³ – (0 to 100) dB (0 to 80) dB	100 kHz to 18 GHz	0.24 dB	Agilent 8902A, 11792A
	(18 to 40) GHz	0.31 dB	Agilent E8364B, N4693A cal kit
SWR of Power Sensor ³	100 kHz to 50 GHz	0.25 dB	Agilent 8757D
Source Errors for CISPR Bands A and B for Impulse Spectral Amplitude ³	Band A (10 to 150 kHz)	0.82 dB	IGUU 2916
	Band B (0.15 to 30 MHz)	0.82 dB	
Source Errors for CISPR Bands C and D for Impulse Spectral Amplitude ³	Band C and D (30 to 1000 MHz)	1.1 dB	IGUU 2916

Parameter/Equipment	Frequency	CMC ^{2, 6, 9} (\pm)	Comments
Pulse Generator ³ – Level Change	Band A through D	0.5 dB	Agilent E4440
Source Errors for Sinewave Output for CISPR Checks ³ (at 60 dB/ μ V)	100 kHz (1, 10, and 100) MHz	0.26 dB 0.26 dB	IGUU 2916
Peak & Average Detector Response ³	Band A through D	1.3 dB	IGUU 2916
Source Errors for Frequency Response ³	Band A Band B Band C Band D	0.53 dB 0.62 dB 0.57 dB 0.69 dB	Agilent 8565E
Impulse BW Measurement ³	Above 1 GHz	3.7 kHz	Agilent 83630B, 33250A
Range to Range Calibration Uncertainty ³	(3, 10, 30, 100, 300) μ W (1, 3, 10, 30, 100) mW	0.49 % 0.49 %	Agilent 11683A
RF Power Sensor Transfer ³ – 10 μ W to 25 mW	10 MHz to 10 GHz (10 to 18) GHz 100 kHz to 4.2 GHz	$M + 1.4$ % $M + 1.4$ % $M + 1.4$ %	Tegam 1803A with 1805B Tegam F1119 with 1805B
Power Meter Accuracy Check ³	(0.1 to 10) mW (0.01 to 0.03) mW	1.4 % 1.5 %	Agilent 432A
Time Base Accuracy for Oscilloscope Measurement ³	Up to 10 μ s	0.34 %	Fluke 9500 oscilloscope calibration system

Parameter/Equipment	Frequency	CMC ^{2, 5, 9} (\pm)	Comments
Bandwidth Measurement ³	1 MHz to 2.5 GHz	0.1 %	Fluke 9500 oscilloscope calibration system
Square Wave Measuring Equipment ³	50 kHz to 2.5 GHz	0.3 % + 1 μ V	Fluke 9500 oscilloscope calibration system
Level Sine Flatness Measurement ³	50 kHz to 250 MHz 250 MHz to 2.5 GHz	1.7 % 4.6 %	Fluke 9500 oscilloscope calibration system
Time Marker Output Measuring Equipment ³	50 kHz to 2.5 GHz	0.004 %	Fluke 9500 oscilloscope calibration system
Non-Sweep Linearity Test (NA) ³	(-90 to +20) dBm	0.24 dB	Agilent 438A, E4418B, Agilent 8481D
Frequency Accuracy Test (NA) ³	10 Hz to 26.5 GHz	12 Hz	Agilent 53151A rubidium frequency standard
Source Level Accuracy/Flatness Test (NA) ³	10 Hz to 50 GHz	0.14 dB	Agilent 438A, E4418B, 8482A, 8487A, and 34401A
Power Sweep Linearity Test (NA) ³	(0 to 20) dB	0.23 dB	Agilent 438A, E4418B, and 8481D
Harmonics/Non-Harmonic Test (NA) ³	(-30 to -120) dBc	0.46 dB	Agilent 8563E
Receiver Noise Level Test (NA) ³	(-30 to -120) dBm	0.31 dB	HP909C, opt 012
Input Crosstalk Test (NA) ³	(-30 to -120) dB	0.23 dB	Agilent 909C, opt 012

Parameter/Equipment	Frequency	CMC ^{2, 5, 9} (\pm)	Comments
Input Impedance Test (NA) ³	(0 to 110) dB	0.37 dB	Agilent 8753D/E
Absolute Amplitude Accuracy Test (NA) ³	(0 to -60) dBm	0.13 dB	Agilent 438A, E4418B, and 8482A
Magnitude Ratio/Phase Dynamic Accuracy Test (NA) ³ –			
Magnitude Ratio Dynamic	(0 to -100) dB	0.37 dB	Agilent 11667A, P8496A/G, and N4693A
Phase Dynamic	(0 to -100) dB	0.06°	
Receiver Trace Noise (NA) ³	300 kHz to 50 GHz	0.33 dB	Agilent 11850C
Magnitude Ratio/Phase Frequency Response Test (NA) ³ –			
Magnitude Ratio Accuracy	100 kHz to 50 GHz	0.37 dB	Agilent 1167A, P8496A/G, and N4693A
Phase Frequency Response	100 kHz to 50 GHz	0.6°	
Receiver Input Impedance (NA) ³	(0 to 120) dB return loss	0.37 dB	Agilent 85032B, N4693A
Receiver Magnitude Accuracy (NA) ³	300 kHz to 50 GHz	0.1 dB	Agilent 438A, E4418B, 8482A, 8487A
Receiver Phase Compression (NA) ³	300 kHz to 50 GHz	0.1 dB	Agilent 438A, E4418B, 8482A, 8487A
Port Match (NA) ³	300 kHz to 50 GHz	0.1 dB	Agilent 85032B, 85044A N4693A

Parameter/Equipment	Frequency	CMC ^{2,4,9} (±)	Comments
Switch Repeatability (NA) ³	300 kHz to 50 GHz	0.1 dB	Associated network analyzer used with S parameter test set
Effective Source Match (NA) ³	300 kHz to 50 GHz	0.1 dB	Agilent 85031B, N4693A
Directivity ³	300 kHz to 50 GHz	0.1 dB	Agilent 85031B, N4693A
Current Monitor Conversion Factors ³	(0.001 to 1) V/A	0.05 %	Fluke 5700A, Agilent 3458A

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comments
ESD Simulators ³ –			EN 61000-4-2;
Contact Voltage (Positive and Negative)	(2 to 8) kV	1.9 %	TEK TDS 540 with 6015A probe; Agilent 54845A with IEC ESD target
Rise Time	(0.7 to 1) ns	61 ps	
Peak Current	(6.8 to 33) A	2.6 %	
30 ns Current	(2.8 to 20.8) A	3.5 %	
60 ns Current	(1.4 to 10.4) A	9 %	
Air Discharge Voltage (Positive and Negative)	(0 to 25) kV	1.9 %	TEK TDS 540 TEK 6015A probe IEC ESD target
Rise Time	(0.7 to 1) ns	61 ps	
RC Time Constant (at ± 15 kV)	600 ns ± 130 ns (for 330 pF probe)	61 ps	
	300 ns ± 60 ns (for 150 pF probe)	61 ps	
Indicated Voltage	(2 to 25) kV	1.9 %	SAE J1113-13 with 54845A and target

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comments
EFT/Burst Generator ³ –			EN 61000-4-4; IEC 61000-4-6; GR 1089 CORE
Voltage	10 V to 6 kV	2.8 %	
Rise Time	5 ns ± 30 %	0.74 ns	Tektronix TDS 5104B
Impulse Duration	50 ns ± 30 %	0.74 ns	
Burst Duration	15 ms ± 20 %	0.74 ns	
Burst Period	300 ms ± 20 %	0.74 ns	
Repetition Rate			
0.125 kV	5 kHz ± 20 %	23 Hz (freq)	
0.25 kV	5 kHz ± 20 %	2.8 % (volt)	
0.5 kV	5 kHz ± 20 %		
1.0 kV	5 kHz ± 20 %		
2.0 kV	2.5 kHz ± 20 %		
Surge Generator ³ –			EN61000-4-5; IEC61000-4-8; IEC61000-4-9; , IEC61000-4-10; IEC61000-4-11; IEC6100-4-12 UL 864; UL 1449; ISO 7637-2; ISO 17069 ITU Rec K.17, K.20, ITU Rec K.21; SBC-TP-76200;
Front Time	(1.2 to 50) µs	0.74 ns	
Rise Time			
Open Circuit	(1.2 to 50) µs	1.2 ns	
Short Circuit			
Time to Half-Value	(20 to 700) µs	0.74 ns	
Open Circuit Voltage	10 V to 12 kV	2.8 %	
Short Circuit Current	(0.125 to 3) kA	2.8 %	
Ring Wave Voltage	1 kV ± 10 %	2.8 %	
Ring Wave Rise Time	1.5 µs ± 0.5 µs	0.74 ns	
Ring Wave Frequency	5 kHz ± 1 kHz	23 Hz (freq) 2.9 % (volt)	GR1089CORE Tektronix TDS 5104B ANSI 62.41, 1991

Parameter/Equipment	Range	CMC ^{2,9} (±)	Comments
Mains Harmonic Emissions ³	(100 to 280) V (0.1 to 20) A (20 to 60) A (0.5 to 179.5)°	0.07 % + 270 mV 0.2 % 0.1 A 0.1°	IEC 61000-3-2; IEC 61000-4-7; IEC 61000-4-13; IEC 61000-4-14; IEC 61000-4-15; 61000-3-11
Voltage Fluctuations (Flicker) ³	(100 to 280) V (0.1 to 20) A (20 to 60) A	0.1 % + 370 mV 0.2 % 0.1 A	IEC 61000-3-3 61000-3-12
Rise/Fall Time ³ – Measure Voltage Measure	(200 ps to 1000 s)/div (1 mV to 10 V)/div	2 % + 50 ps 2 %	TDS 5104B TDS 5104B

¹ This laboratory offers commercial and field calibration service.

² Calibration and Measurement Capability (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. Calibration and Measurement Capabilities represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration and this laboratory meets A2LA R104 – *General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ The measurands stated are generated with the Fluke 5000A series of instruments. This capability is suitable for the calibration of the devices intended to measure the stated measurand in the ranges indicated. CMCs are expressed as either a specific value that covers the full range or as a fraction of the reading plus a fixed floor specification.

⁵ The measurands stated are measured with the Agilent 3458A or the Agilent 8487A or the Fluke 8508A. This capability is suitable for the calibration of the devices intended to generate the measurand in the ranges indicated. CMCs are expressed as either a specific value that covers the full range or as a combination of the fraction of the reading/output plus a range specification.

⁶ In the statement of CMC, M is the mismatch uncertainty for the unit under test. Mismatch uncertainties, due to the reflection coefficient of the device to be calibrated, are to be included in the overall measurement uncertainty. The approach of determining expanded uncertainties, expressed at approximately the 95 % level of confidence, (using a coverage factor of $k = 2$) is to be applied for this calculation as well.

⁷ Instruments are calibrated against manufacturer's specifications. These calibrations may also, at customer request, be based on conformance to the calibration requirements of various standards such as CISPR 16-1-1, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-11, EN 61000-4-5, IEC 61000-4-2, IEC 61000-3-2, IEC 61000-4-7, IEC 61000-4-8, IEC 61000-4-9, IEC 61000-4-10, IEC 61000-4-11, IEC 61000-4-12, IEC 61000-4-13, IEC 61000-4-14, IEC 61000-4-15, ANSI 62.41:1991, ANSI C63.16, ANSI C62-41, UL 864, UL 1449, ISO 7637-2, ISO 17069, ITU Rec K.17, ITU Rec K.20, ITU Rec K.21, SBC-TP-76200, GR1089CORE and SAE J1113-13. Other standards may apply and the customer should contact the lab for further information.

⁸ Some of the types of instruments calibrated under these parameters are EMI Receivers, EFT/Burst Generators, ESD Guns and Targets, Surge Generators, Generators for Voltage Dips, Short Interrupts and Variations, Ring Wave Generators, Network Analyzers, Click Analyzers, Impulse Generators, Power Meters, Power Sensors, Signal Generators, Spectrum Analyzers, Attenuators and Terminations.

⁹ In the statement of CMC, all percentages shall be read as percent of reading, unless otherwise noted.



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Presented this 25th day of October 2011.





Peter Meyer

President & CEO
For the Accreditation Council
Certificate Number 1818.01
Valid to September 30, 2013

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.